

Notice of References Cited

Application/Control No.

09/475,135

Applicant(s)/Patent Under
Reexamination
KWEON ET AL.

Examiner

BRIAN P. YENKE

Art Unit

2614

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,678,006	01-2004	Velez et al.	348/564
	B	US-6,678,007	01-2004	Nason et al.	348/564
	C	US-6,700,625	03-2004	Fujii, Tadashi	348/588
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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